

2634



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

#11

Applicants: Takahiro Yamaguchi, et al.
Serial No.: 09/811,153
Filing Date: March 16, 2001
Title: Apparatus for and Method of
Measuring Jitter

Examiner: Mohammad Ghayour

Art Unit: 2634

RECEIVED

DEC 13 2002

Technology Center 2600

December 6, 2002
San Francisco, California

Commissioner of Patents
Washington, DC 20231

INFORMATION DISCLOSURE STATEMENT

Sir:

Pursuant to the duty of disclosure set forth in 37 CFR § 1.56, Applicants respectfully submit the following information disclosure statement.

The undersigned certifies that the following reference was contained in a communication from a counterpart international application not more than three months prior to the filing of this statement. A copy of the International Search Report is attached.

The disclosed reference is:

Yamaguchi, T., et al., "Extraction of peak-to-peak and RMS sinusoidal jitter using an analytic signal method," Proceedings 18th IEEE VLSI Test Symposium, Montreal, Quebec, Canada, 4/30-5/4/2000, pages 395-402.

Information Disclosure Statement Application No. 09/811,153

Applicants respectfully request that the Examiner initial the cited references shown on the enclosed form PTO-1449 and that the references be made of record in the present application.

Respectfully submitted,



David N. Lathrop
Reg. No. 34,655
601 California St., Suite 1111
San Francisco, CA 94108-2805
Telephone: (415) 989-8080
Facsimile: (415) 989-0910

Certificate of Mailing Under 37 CFR 1.8

I certify that this Information Disclosure Statement and any enclosed materials are being deposited with the United States Postal Service on December 6, 2002 with sufficient postage as first class mail in an envelope addressed to Commissioner for Patents, Washington, DC 20231.



David N. Lathrop

Enc. Cited reference (1)
PTO Form 1449
Return receipt postcard